 	Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/905,341	YANN ET AL.
Examiner	Art Unit
Minh Dieu Nguyen	2137

SEARCHED			
Class	Subclass	Date	Examiner
713	189, 201	7/11/2005	MDN
			·

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	1		
	_		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	7/11/2005	MDN
Updated search on EAST (US-PAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	7/11/2005	MDN
		-
480-1004		
		<u>.</u>
•		